


<b>Search Notes</b>  	<b>Application/Control No.</b>  10774884	<b>Applicant(s)/Patent Under Reexamination</b>  TAGAWA ET AL.
	<b>Examiner</b>  HUY T NGUYEN	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	46, 95, 125	8/13/2007	MD

SEARCH NOTES		
Search Notes	Date	Examiner
INTERFERENCE SEARCH. SEE PRINTOUT	3/16/2008	HN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
INTERFERE NCE SEARCH		3/16/2008	HN